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**Partha Banerjee
Karl Gudmundsson
Akhlesh Lakhtakia
Guru Subramanyam**
Editors

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Introduction

This proceedings volume is the result of the CETRASE's third international workshop on Thin Films for Electronics, Electro-Optics, Energy and Sensors (TFE3S) held at the University of Iceland, Reykjavik, Iceland. The biennial workshop was organized in collaboration with the Pennsylvania State University and the University of Iceland. The purpose of the workshop is to exchange technical knowledge and boost technical and educational collaboration activities within the thin film research community.

Partha Banerjee
Karl Gudmundsson
Akhlesh Lakhtakia
Guru Subramanyam

